



FDP33N25 / FDPF33N25T 250V N-Channel MOSFET

Features

- 33A, 250V, $R_{DS(on)} = 0.094\Omega$ @V_{GS} = 10 V Low gate charge (typical 36.8 nC)
- Low Crss (typical 39 pF)
- Fast switching
- · Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



Absolute Maximum Ratings

Symbol	Parameter		FDP33N25	FDPF33N25T	Unit	
V _{DSS}	Drain-Source Voltag	Drain-Source Voltage		250		V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$) - Continuous ($T_C = 100^{\circ}C$)		33 20.4	33* 20.4*	A A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	132	132*	А
V _{GSS}	Gate-Source voltage		± 30		V	
E _{AS}	Single Pulsed Avalanche Energy (N		(Note 2)	918		mJ
I _{AR}	Avalanche Current		(Note 1)	33		А
E _{AR}	Repetitive Avalanche Energy (f		(Note 1)	23.5		mJ
dv/dt	Peak Diode Recovery dv/dt (Note		(Note 3)	4.5		V/ns
P _D	Power Dissipation	(T _C = 25°C) - Derate above 25°C		235 1.89	37 0.29	W W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300		°C	

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP33N25	FDPF33N25T	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.53	3.4	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP33N25	FDP33N25	TO-220	-	-	50
FDPF33N25T	FDPF33N25T	TO-220F	=	=	50

Electrical Characteristics $T_C = 25\%$ unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Off Charac	teristics	-				
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A, T_J = 25^{\circ}C$	250			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	oltage Temperature I _D = 250μA, Referenced to 25°C		0.25		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 250V, V _{GS} = 0V V _{DS} = 200V, T _C = 125°C			1 10	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V$, $V_{DS} = 0V$			-100	nA
On Charac	teristics				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 16.5A		0.077	0.094	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 16.5A$ (Note 4)		26.6		S
Dynamic C	haracteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		1640	2135	pF
C _{oss}	Output Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz		330	430	pF
C _{rss}	Reverse Transfer Capacitance			39	59	pF
Switching	Characteristics				•	
t _{d(on)}	Turn-On Delay Time	V _{DD} = 125V, I _D = 33A		35	80	ns
t _r	Turn-On Rise Time	$R_G = 25\Omega$		230	470	ns
t _{d(off)}	Turn-Off Delay Time			75	160	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		120	250	ns
Q _g	Total Gate Charge	V _{DS} = 200V, I _D = 33A		36.8	48	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10V		10		nC
Q _{gd}				17		nC
Drain-Sour	ce Diode Characteristics and Maximur	n Ratings			•	
I _S Maximum Continuous Drain-Source Diode Forward Current				33	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode F	orward Current			132	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 33A			1.4	٧
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 33A		220		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s (Note 4)$		1.71		μС

Notes

^{1.} Repetitive Rating: Pulse width limited by maximum junction temperature

^{2.} L = 1.35mH, I $_{AS}$ = 33A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C

^{3.} I $_{SD} \le 33$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T $_{J}$ = $25^{\circ}C$

^{4.} Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$

^{5.} Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

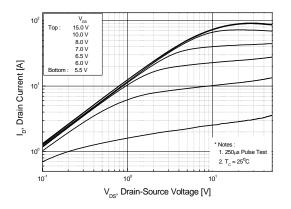


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

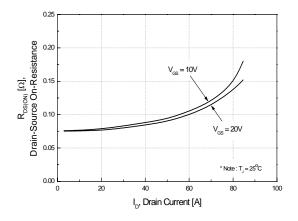


Figure 5. Capacitance Characteristics

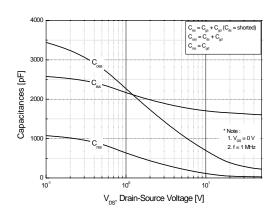


Figure 2. Transfer Characteristics

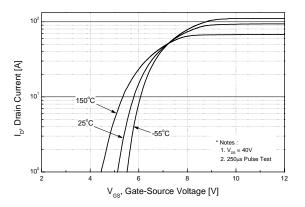


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

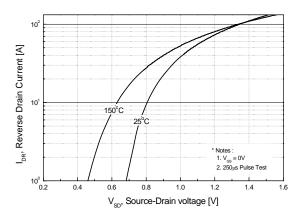
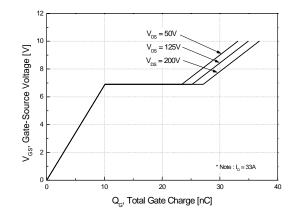


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

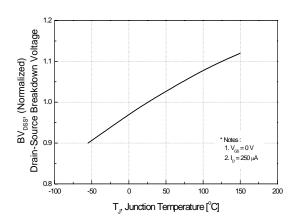


Figure 9-1. Maximum Safe Operating Area for FDP33N25

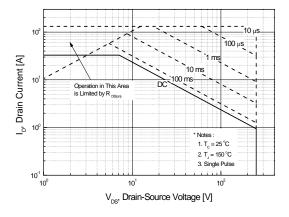


Figure 10. Maximum Drain Current vs. Case Temperature

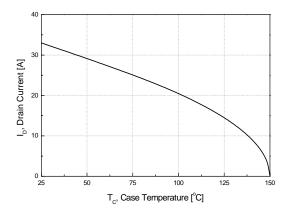


Figure 8. On-Resistance Variation vs. Temperature

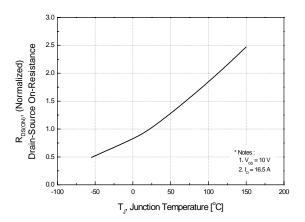
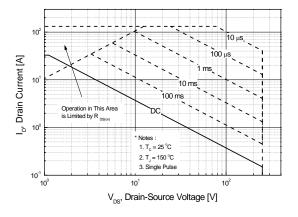


Figure 9-2. Maximum Safe Operating Area for FDPF33N25T



Typical Performance Characteristics (Continued)

Figure 11-1. Transient Thermal Response Curve for FDP33N25

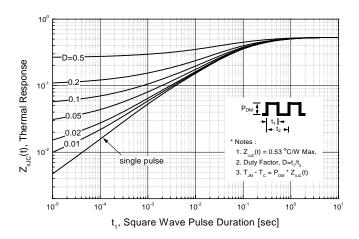
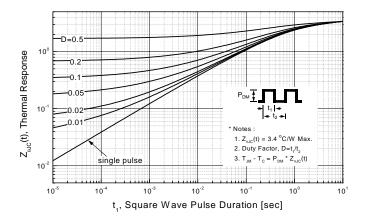
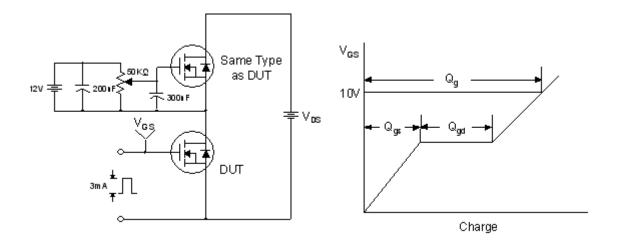


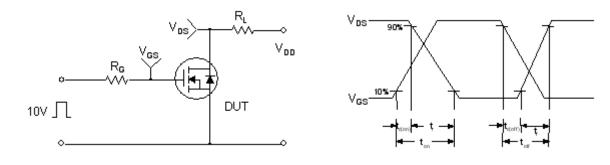
Figure 11-2. Transient Thermal Response Curve for FDPF33N25T



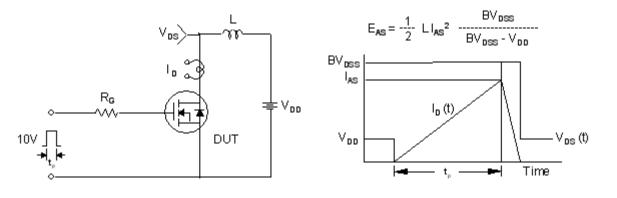
Gate Charge Test Circuit & Waveform



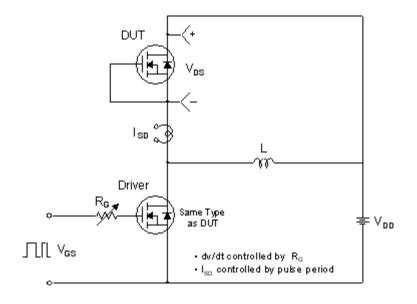
Resistive Switching Test Circuit & Waveforms

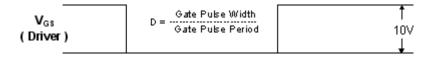


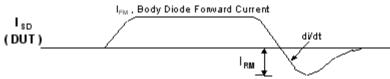
Unclamped Inductive Switching Test Circuit & Waveforms



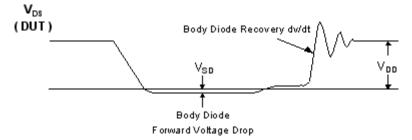
Peak Diode Recovery dv/dt Test Circuit & Waveforms





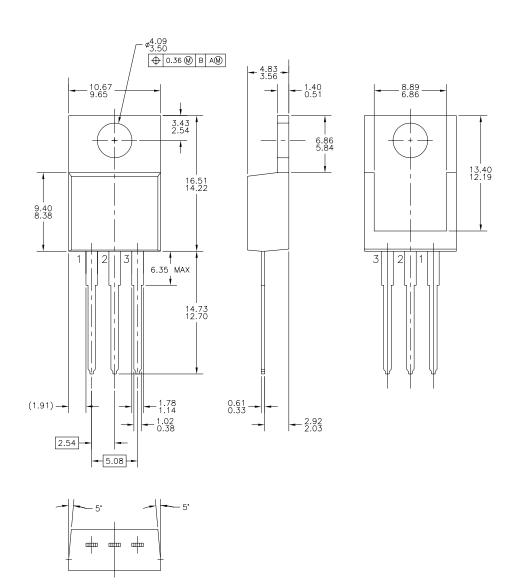


Body Diode Reverse Current



Mechanical Dimensions

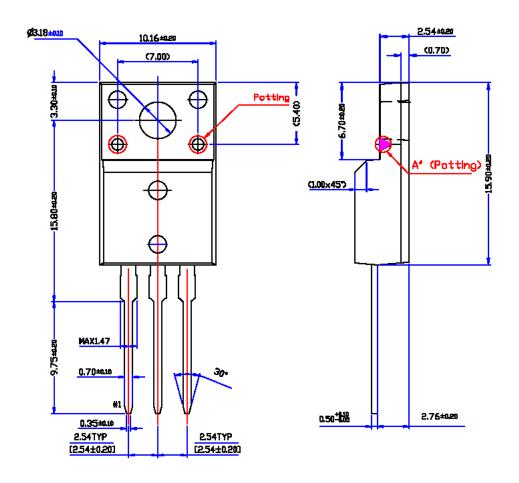
TO-220

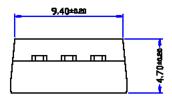


Dimensions in Millimeters

Package Dimensions

TO-220F Potted





* Front/Back Side Isolation Voltage : AC 2500V

Dimensions in Millimeters

Dimensions in Millimeters





TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

interface to be an exhaustive flot of al	rodon tradomanto.	_	
AccuPower™	FPS™	PowerTrench [®]	The Power Franchise®
Auto-SPM™	F-PFS™	PowerXS™	the .
Build it Now™	FRFET [®]	Programmable Active Droop™	puwer"
CorePLUS™	Global Power Resource SM	QFET®	franchise
CorePOWER™	Green FPS™	QS TM	TinyBoost™
CROSSVOLT™	Green FPS™ e-Series™	Quiet Series™	TinyBuck™
CTL™	G <i>max</i> ™	RapidConfigure™	TinyCalc™
Current Transfer Logic™	GTO™	3, 1	TinyLogic [®]
EcoSPARK [®]	IntelliMAX™	TM	TINYOPTO™
EfficentMax™	ISOPLANAR™	Saving our world, 1mW /W /kW at a time™	TinyPower™
EZSWITCHTM*	MegaBuck™	SmartMax™	TinyPWM™
TM*	MICROCOUPLER™	SMART START™	TinyWire™
= 7.	MicroFET™	SPM [®]	TriFault Detect™
R	MicroPak™	STEALTH™	TRUECURRENT™*
F ®	MillerDrive™	SuperFET™	
Fairchild [®]	MotionMax™	SuperSOT™-3	
Fairchild Semiconductor®	Motion-SPM™	SuperSOT™-6	UHC®
FACT Quiet Series™	OPTOLOGIC®	SuperSOT™-8	Ultra FRFET™
FACT [®]	OPTOPLANAR®	SupreMOS™	UniFET™
FAST [®]	®	SyncFET™	VCX™
FastvCore™	(1)	Sync-Lock™	VisualMax™
FETBench™	DDD ODLUTU	SYSTEM ®*	XSTM
FlashWriter® *	PDP SPM™	GENERAL	
	Power-SPM TM	GENERAL SERVICE	

^{*}Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

Power-SPM™

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICYFAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS **Definition of Terms**

Datasheet Identification Product Status		Definition		
		Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.		
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.		
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.		
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.		